Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/711,995	WU ET AL.	
Examiner	Art Unit	
VIJAY SHANKAR	2629	

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Class	Subclass	Date	Examiner
345	156-178	11/1/2006	VS
178	18.0107		
178	19.0106		

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